Racal Instruments

http://www.racalinstruments.com

PRODUCT INFORMATION

225 MHz Universal Counter/Timer Model 2201



- 225 MHz Frequency Measurement and 10 ps Averaged Time Interval Resolution
- Optional High-Stability Oscillator
- Optional Frequency Measurement to 1.3 GHz and OCXO
- Comprehensive Arming
 Capabilities and Trigger Control
- 10 mV Trigger Resolution
- 9 Automatic Measurements, Including Peak Signal Amplitude

The Model 2201 is a high-performance, 2channel, 225 MHz Universal Counter/Timer for applications from R&D benchtop to Automatic Test Equipment. The module offers nine automatic measurement functions and contains an optional 1.3 GHz third input available for RF requirements.

Brief Description

The 2201 offers nine automatic measurement functions:

- Frequency
- Period
- Time Interval
- Time Interval Delay
- Pulse Width
- Frequency Ratio Channel A to B
- Totalize
- Phase
- Peak Signal Voltage

High-Performance Trigger

The manual trigger mode is programmable from -5.1 V to + 5.1 V (-51 V to + 51 V in X10 mode) with an exceptional resolution of 10 mV (100 mV in X10 mode). An automatic trigger mode is also available covering the frequencies from 100 Hz to 150 MHz.

Automatic Attenuation Selection

Automatic trigger mode automatically switches attenuator settings if the input signal exceeds 5.1 Vpk-pk.

DVM Measurements

Automatic triggering establishes the peak voltages for setting trigger points. Users employ this feature to measure peak voltage levels.

Individual Channel Filtering

The 2201 contains an independent 100 kHz low-pass filter on each channel to reduce input stage sensitivity when making low-frequency measurements.

High-Stability Time Base

Users may improve stability by using an external clock or one of the two optional internal high stability time bases. The internal time base options are:

- TCXO: Standard
- OCXO: Option 11

Optional Analog Output

Option 08 (Analog Output) provides a high-accuracy source to drive devices like chart recorders. This option is especially useful in measuring and recording the aging and temperature stability of devices like oscillators and Voltage to Frequency (V-F) converters.

Flexible Gate Time and Delay Time Control

The Model 2201 allows fine control of gate-time and delay-time settings with 46 pre-defined times ranging from 100 μ s to 10 seconds. In addition, gate or delay may be set to any value between 100 μ s and 1000 seconds using an external input.

Up to 9-Digit Resolution

2nd Function Key accesses Hold, Averaging, Peak Volts, Delay, Auto Trigger, Digits, Analog Output, Offset, and GPIB Address

AUTOMATIC FUNCTIONS



2201 SPECIFICATIONS

Selection

Frequency Channels A & B: DC to 225 MHz Channel C (Option 41): 50 MHz to 1.3 GHz Accuracy: \pm (Resolution \pm Timebase Error \times Freq) Resolution \leq 10 MHz: (\pm LSD \pm $[1.4 \text{ x TrigError} + 2ns] \times Freq)$ /GateTime Resolution > 10 MHz: ± LSD LSD ≤ 10 MHz: (40ns / Gate Time) x Freq. LSD > 10 MHz: 4 / Gate Time) Period A, Pulse Width A, Time Interval A to B Range: 10 ns to 10,000 s Accuracy: ± Resolution ± (TimebaseError \times Time) ± TriaLevelTiminaError± 2 ns Resolution: ±1 LSD ± StartTrigError ± StopTrigError LSD (Time < 100 s): 100 ns LSD (Time > 100 s): $5 \times 10^{-9} \times$ Time Period A (Averaged) Range: 8 ns to 10 s Accuracy: ± Resolution ± TimebaseError x Period Resolution: \pm 1 LSD \pm (1.4 \times TrigError + 2 ns) × Period / GateTime LSD: 40 ns × Period / GateTime Number of Periods Averaged: N =GateTime / Period Pulse A, Time Interval A to B (Averaged) Range (Pulse Width A): 5 ns to 10 s Range (T.I. A to B): 0 ns to 10 s Accuracy: ± (Resolution ± TrigError) / $\sqrt{N\pm}$ TimebaseError x Time ± 2ns Resolution: ± 1 LSD LSD: 50 ns 🛵

Dead Time Stop to Start (Min.): 20 ns Number of Samples Averaged: N =GateTime × FreqA Phase A to B (Averaged) Phase Range: 0 to $360^{\circ} \times (1 - 20)$ ns ×FreqA) Frequency Range: 0.1 Hz to 25 MHz Accuracy: ± Resolution ± 2 ns x FreqA x 360° ± (TrigError x FreqA x 360°) /_{√N} Resolution: ±1 LSD LSD: 25 ns x 360° x (1+ \sqrt{N})/ GateTime or 0.01°, whichever is greater Number of Cycles Averaged: N=GateTime x FreqA Minimum Amplitude: 100 mVrms sine wave **Time Interval Delay** (Delays Start of Time Interval Measurements.) Range (Internal): 100 µs to 10 s Range (External): 100 us to 10,000 s **Frequency Ratio** (Channel A to Channel B) Channel A Range: 0.1 Hz to 225 MHz Channel B Range: 0.1 Hz to 125 MHz Accuracy & Resolution: ± (LSD ± TrigErrorB x Ratio) / GateTime LSD: 4 \times Ratio / (FreqA \times GateTime) Totalize (Channel B by Channel A) Frequency Range: 0 to 100 MHz Events: 0 to 1016-1 Start/Stop Control: Channel A Accuracy: \pm (PulseRepRateB \times TrigError A) / TotalCountsB Resolution: 1 LSD LSD: 1 count Dead Time (Stop to Start): 20 ns

Peak Signal (Maxima or Minima) Frequency Range: 40 Hz to 10 MHz Dynamic Range: 280 mVpk-pk to 51 Vpk-pk Accuracy: ± Resolution ± (10% of Vpk-pk) ± 35m V Resolution: 10 mV (× Atten)

INPUT CHARACTERISTICS

(Input Channels A and B) Frequency Range (DC Coupling) DC to 225 MHz Frequency Range (AC Coupling) 1 MΩ: 30 Hz to 225 MHz 50 Ω: 1 MHz to 225 MHz Low-Pass Filter (Selectable) 100 kHz BW, nominal Selectable Input Features Impedance: 50 Ω or 1 M Ω Coupling: AC or DC Attenuation: ×1 or ×10 Trigger Slope: + or -Sensitivity (Sine Wave, ×1 Atten) < 100 MHz: 35 mVrms < 225 MHz: 50 mVrms Sensitivity (Pulse, 5 ns Width, ×1 Atten)100 mVpk-pk Dynamic Range (x1 Atten.) < 100 MHz: 34 dB (100 mVpk-pk to 5 Vpk-pk) < 225 MHz: 24 dB (150m Vpk-pk to 2.5Vpk-pk) Damage Level (AC or DC) 50 Ω: 5 Vrms 1 MΩ, DC to 2 kHz (× Atten): 200 V (DC + peak AC) 1 M Ω , 2 kHz (× Atten) to 100 kHz: 4 x 10⁵ Vrms ⋅ Hz x Atten/Freq 1 MΩ, > 100 kHz: 5 Vrms (× Atten)

INPUT CHARACTERISTICS

(Option 41: Input Channel C) **Frequency Range** 50 MHz to 1.3 GHz Input Impedance 50 Ω . nominal Coupling AC Sensitivity (Sine Wave) \leq 1.0 GHz: 25 mVrms \leq 1.3 GHz: 50 mVrms **Dynamic Range** ≤ 1.0 GHz: (25 mV to 1 Vrms) 32 dB ≤ 1.3 GHz: (50 mV to 1 Vrms) 26 dB **Damage Level** DC to 100 kHz: 15 V (DC + peak AC) 100 kHz to 1.3 GHz: 5 Vrms GATE AND DELAY TIME Modes Internal Gate: Programmable External Gate: Rear Panel BNC (except TI, PW, and Totalize) Internal Delay: Programmable (TI only) External Gate: Rear Panel BNC (TI only) Internal Range (Gate & Delay) 100 μ s to 10 s or one period of the input Internal Resolution (Gate & Delay) \leq 1 ms: 100 µs \leq 10 ms: 1 ms ≤ 100 ms: 10 ms ≤ 1 s: 100 ms ≤ 10 s: 1 s **External Gate Time Range** 100 us to 1000 s **External Delay Range** 100 µs to 1000 s **External Gate Delay**

< 10 µs

10 MHz TIMEBASE CHARACTERISTICS Standard TCXO

Aging Rate: 0.1 ppm/month Temperature Stability: 1 ppm, 0° C to 40° C Line Voltage: 0.1 ppm, 10% change (short term) **Optional OCXO** (Option 11) Accuracy: 0.01 ppm Temperature Stability: 0.1 ppm, 0° C to 60° C Aging Rate: 0.1 ppm/year Warm-up Time: 0.1 ppm in 3 min. **External Frequency Standard Input** Rear Panel BNC

TRIGGERING CHARACTERISTICS General (Manual or Autotrigger) Range: ±5 V (× Atten), programmable Accuracy: ± 3% of TrigLevel \pm 35 mV (\times Atten) Resolution: 10 mV (× Atten) **Trigger-Level Outputs** Accuracy: $\pm\,50$ mV $\pm\,5\%$ of TrigLevel Auto Trigger Range (DC & 1 MΩ, AC): 100 Hz to 150 MHz (Usable to 225 MHz) Range (50 Ω, AC): 1 MHz to 150 MHz (Usable to 225 MHz) Minimum Amplitude: 100 mVrms (280 mVpk-pk) Auto Attenuation Mode: Automatically enabled in Autotrigger mode, peak $> \pm 5.1$ V or when the difference between maximum and minimum peaks exceeds 5.1 V. **External Arming** Operation: Arms the instrument when set to HOLD mode Trigger Delay: < 50 μs Minimum Pulse Width: 10 µs PANEL I/O Front Inputs Channel A: BNC, 50 Ω or 1 MΩ Channel B: BNC, 50 Ω or 1 MΩ Channel C (Option 41): BNC, 50 Ω **Front Inputs** External Arm/Gate/Delay: BNC, 1 k Ω **External Frequency Standard:** BNC, 10 MHz, TTL **Rear Outputs** Frequency Standard: BNC, 10 MHz, > 2 V Trigger Level Outputs: Terminals, 1 kΩ **OPTIONAL FEATURES Option 08: Analog Output** Range: 0 to 9.99 V Tracking: Any 3 consecutive digits Normal: Output proportional to Digits Offset: Offset added to output Offset Range: 0-9 V, 1 V resolution Accuracy and Nonlinearity: ±2 mV Output Impedance: 1 kΩ

Settling Time: 1 ms after measurement end Option 11: OCXO 10 MHz Reference

Front Panel Output: BNC Specifications: Per Timebase Specification

Option 41: 1.3 GHz Input C Frequency Range: 50 MHz to 1.3 GHz Specifications: Per Input Characteristics

Option 60A: Rack Mount Kit For 19" Rack Mounting **GPIB INTERFACE DATA Programmable Features** All front panel controls except POWER switch IEEE 488.1 Support Multiline: DCL, LLO, SDC, GET, GTL, UNT, UNL, SPE, SPD Uniline: IFC, REN, EOI, SRQ, ATN Interface: SH1, AH1, T6, TE0, L4, LE0, SR1, RL1, PP0, DC1, DT1, C0, E1 **Data Formatting** Measurements (with prefix): 18 ASCII characters plus terminator Measurements (without prefix): 14 ASCII characters plus terminator Gate/Delay Time & Trigger Level (with prefix): 9 ASCII characters plus terminator Gate/Delay Time & Trigger Level (without prefix): 5 ASCII characters plus terminator Address Selection Via front panel control, address is stored in a non-volatile memory. GENERAL **Display Rate** Normal: 4 Readings/second Fast: 27 Readings/second Display Digits: 9 for mantissa, 2 for exponent Gate: LED lights when gate is open Non-Volatile Setups Including: Trigger levels, gate/delay time, input conditioning and measurement rate Storage Life: 5 years Drivers LabVIEW, LabWindows/CVI **Power Requirements** 115/230 V_{rms} ±10%, 48-63 Hz, 40 W max Voltage Range Selection Rear panel switch **Accessories Furnished** Power Cord, User's Manual, Drivers

ENVIRONMENTAL

Temperature Operating: 0° C to 40° C, 0 to 80% RH Storage: -25° C to 65° C Warm-up 1 hour to rated accuracy and stability Weight 8.8 lbs. (4 kg) Dimensions 3.43" H x 8.27" W x 15.35" D Workmanship Standards Conforms to IPC-A-610D EMC (Council Directive 89/336/EEC) EN55011, Group 1, Class A EN50082-1, IEC 801-2,3,4 Safety (Low-Voltage Directive 73/23/EEC) IEC1010-1, UL3111-1, CSA 22.2 #1010





DEFINITIONS OF TERMS LSD:

Unit value of least significant digit, rounded as follows: 1 to < 5 Hz -> 1 Hz, 5 ns to 10 ns > 10 ns, etc.

Trigger Error (TrigError):

$$\frac{\sqrt{(e_i^2 + e_n^2)}}{S_i}$$

where.

 e_i is the rms noise voltage of the

counter's input channel (250µV, typical)

 e_n is the rms noise voltage of the

input signal in a 225MHz bandwidth

 S_i is the input slew rate at the trigger point

TimebaseError (TimeBaseError): Maximum fractional frequency change in the timebase due to all errors, e.g., aging, temp., line voltage, etc.

Trigger-Level Timing Error

(TrigLevelTimingError):

18 mV	18 mV
S _{i@start}	S _{i@stop}

External Arming Trigger Delay: Delay from the positive going slope of the gating signal to the internal gate open signal.

External Gate Delay:

Delay from the positive going slope of the gating signal to the internal gate open signal.

Dead Time:

Minimum time between measurement which the counter is busy processing and the next measurement. During dead time, the counter will not respond to any input transition.

ORDERING INFORMATION		
Model	Description	Part Number
2201	225 MHz Universal Counter/Timer (GPIB, TCXO)	407743-000
2201 w/ Option 11	225 MHz Universal Counter/Timer (GPIB, OCXO)	407743-001
2201 w/ Option 8	225 MHz Universal Counter/Timer (GPIB, TCXO, Analog Output)	407743-010
2201 w/ Option 8 and 11	225 MHz Universal Counter/Timer (GPIB, OCXO, Analog Output)	407743-011
2201 w/ Option 41	1.3 GHz Universal Counter/Timer (GPIB, TCXO)	407743-100
2201 w/ Option 41 and 11	1.3 GHz Universal Counter/Timer (GPIB, OCXO)	407743-101
2201 w/ Option 41 and 8	1.3 GHz Universal Counter/Timer (GPIB, TCXO, Analog Output)	407743-110
2201 w/ Option 41, 8, and 11	1.3 GHz Universal Counter/Timer (GPIB, OCXO, Analog Output)	407743-111
Option 60A	19" Rack Mounting Kit	407745

The CE Mark indicates that the product has completed and passed rigorous testing in the area of RF Emissions, Immunity to Electromagnetic Disturbances and complies with European electrical safety standards.

The Racal policy is one of continuous development; consequently, the equipment may vary in detail from the description and specification in this publication.

Racal Instruments, Inc., 4 Goodyear St., Irvine, CA 92618-2002. Tel: (800) RACAL-ATE, (800) 722-2528, (949) 859-8999; FAX: (949) 859-7139 Racal Instruments Ltd., 480 Bath Road, Slough, Berkshire, SL1 6BE, United Kingdom. Tel: +44 (0) 1628 604455; FAX: +44 (0) 1628 662017 Racal Systems Electronique S.A., 18 Avenue Dutartre, 78150 LeChesnay, France. Tel: +33 (1) 3923 2222; FAX: +33 (1) 3923 2225 Racal Systems Elettronica Srl, Strada 2-Palazzo C4, 20090 Milanofiori Assago, Milan, Italy. Tel: +39 (0)2 5750 1796; FAX +39 (0)2 5750 1828 Racal Instruments GmbH, Technologiepark Bergisch Gladbach, Friedrich-Ebert-Strasse, D-51429 Bergisch Gladbach, Germany. Tel: +49 2204 8442 00; FAX: +49 2204 8442 19



Racal Australia Pty Ltd., 3 Powells Road, Brookvale, NSW 2100, Australia. Tel: +612 9936 7000; FAX: +612 9936 7036

